

Reflection self-seeding at SACL

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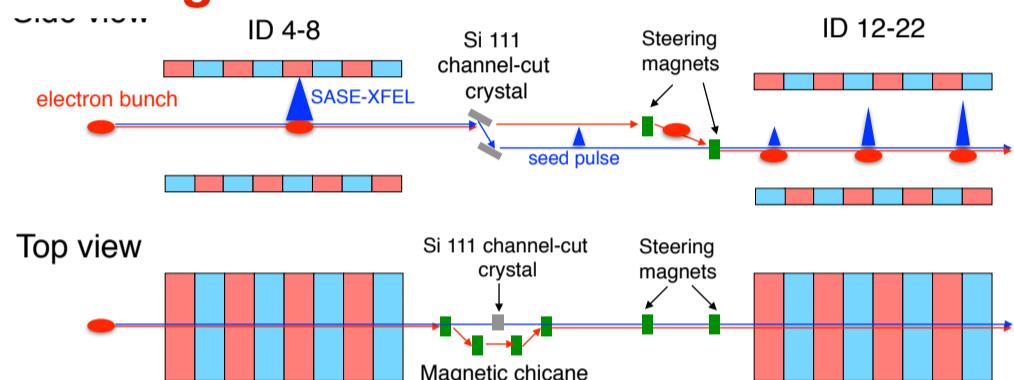
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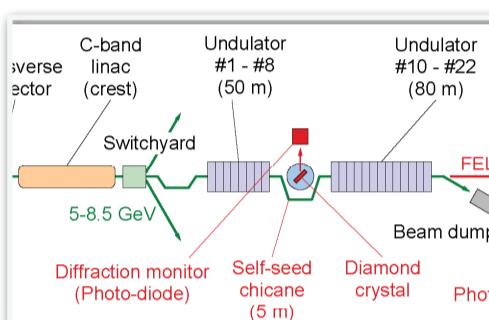
summary

ed based on the SASE scheme, where spontaneous radiation originating from density modulations in the electron beam is amplified along periodic magnetic field in undulators. Although the SASE scheme is effective to produce intense X-ray beams, the stochastic starting-up processes cause poor temporal coherence and a broad spectrum. Here, we present an efficient seeding scheme for producing narrowband XFEL beams; the SASE-XFEL beam in the first-half undulators is monochromatized via Bragg reflection of a silicon channel-cut crystal, and the monochromatic seed is amplified in the remaining undulators. We applied this scheme to SACL, and produced nearly Fourier-transform-limited XFEL pulses, corresponding to an increase of spectral brightness by a factor of six with respect to the SASE-XFEL. This achievement will not only enhance the throughput of the present XFFI experiments but also open new opportunities of X-ray sciences.

Concept of reflection self-seeding

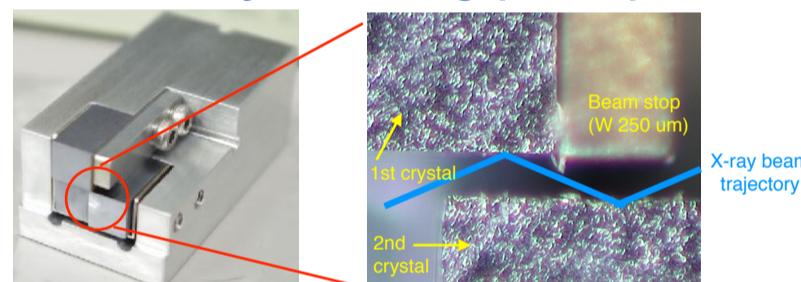


cf. transmission self-seeding using thin diamond



LCLS: J. Amann *et al.*, Nature Photon. (2012).
SACL: T. Inagaki *et al.*, Proc. FEL 2014.

Channel-cut crystal with a gap of 90 μm



Purely mono-XFEL beam is delivered to downstream IDs

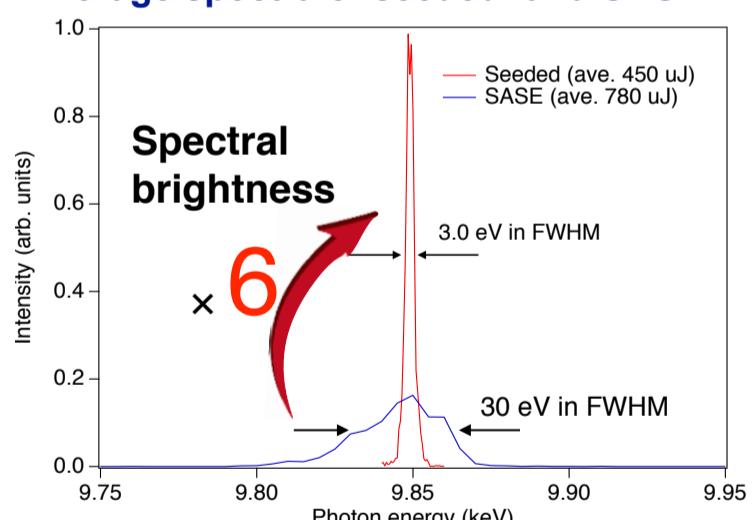
No SASE contamination to the seed pulse

High extraction efficiency of mono-beam from SASE-FEL

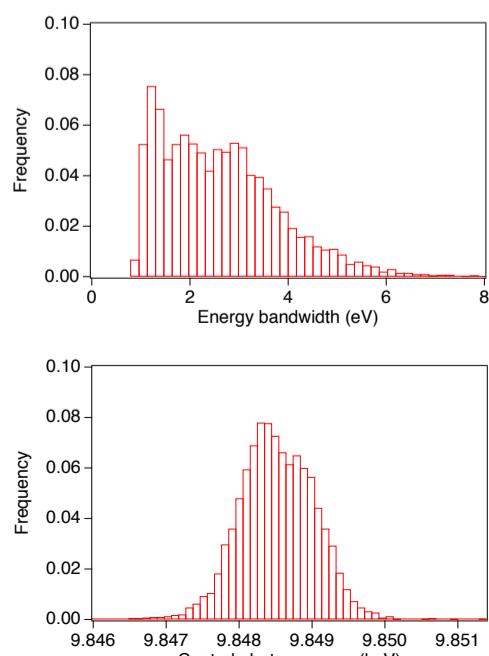
$$\frac{(\text{Seed power})}{(\text{Input SASE power})} = \begin{cases} \sim 3 \times 10^{-2} & \text{for reflection seeding (Si 111 channel cut)} \\ \sim 5 \times 10^{-3} \text{ or less} & \text{for transmission seeding (C400, 100 } \mu\text{m)} \end{cases}$$

Properties of seeded-XFEL

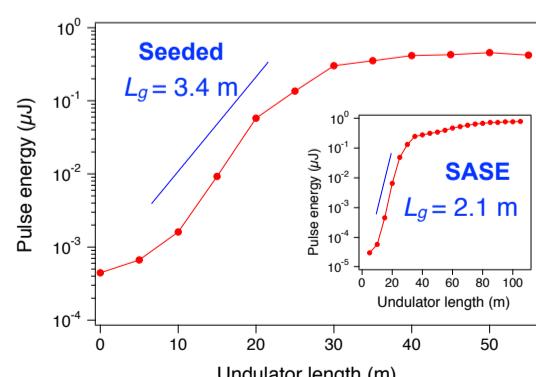
Average spectra of seeded- and SASE-XFEL



Statistics of beam properties

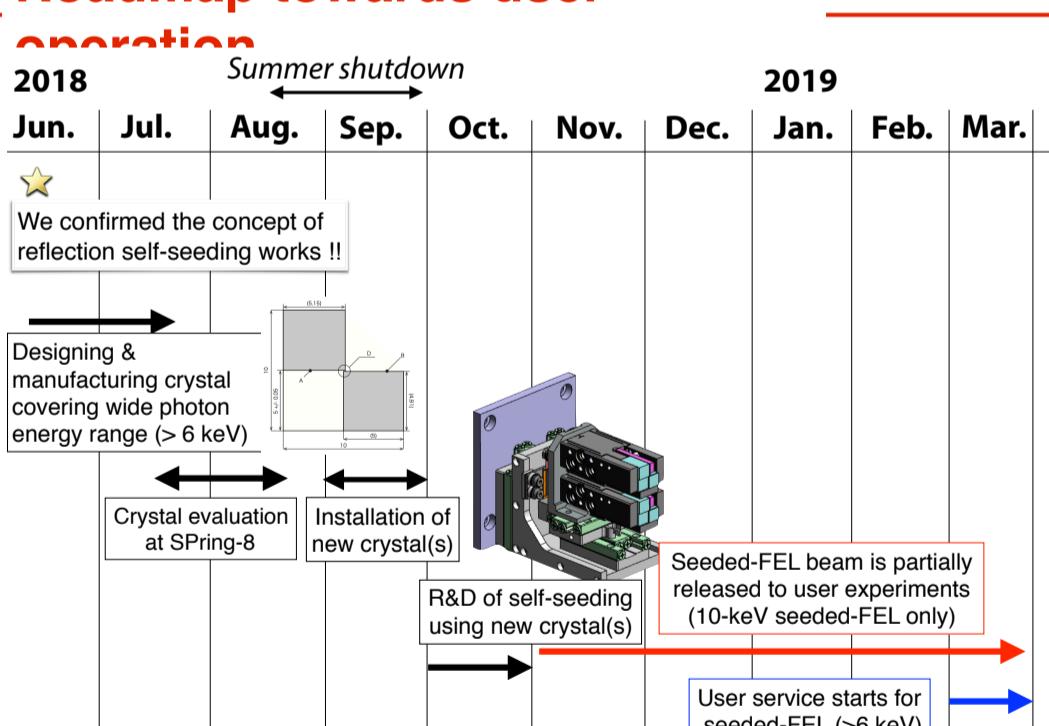


Gain curves of seeded- and SASE-XFEL



- Seeded-XFEL reaches saturation
- Gain length of seeded-XFEL is comparable to that of SASE-XFEL, indicating that high quality e-beam was injected to the second-half undulators

Roadmap towards user operation



Let us know what kind of sciences do you want to perform with seeded-XFEL !!!